CRITICAL ITEMS LIST

ASSY, NOMENCLATURE __CCTY/ITVC_

ASSY. P/N _2000744261

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NAME, QTY & DRAHINGS REF. DESIGNATION	FUNC1104	FAILURE MODE AND CAUSE	END 11£m	INTERFACE	l .	CREW/	RATIONALS FOR ACCEPTANCE	DATE
REF. DESIGNATION ITVC, 1, Elbow Stack 2000744261 ITVC, 3.6.1		Lens motion function of zoom, focus and iris do not respond to commands. (Electrical Failure).		No Video	Loss of Mission Critical Video	Nane	See Sheet 2	

MP/27290

DESIGN FEATURES

The ITYC is comprised of 20 electrical subassemblies: 13 subassemblies are Lockheed Martin Astro Space designed and fabricated using standard printed circuit hoard type construction. The remaining six assemblies, 3 stepper motors, High Voltage Power Supply (HVPS), Intensified CCD (1CCD), and Loss assembly are vendor supplied commonests, which have been specified and purchased according to Lockhood Martin Specification Control Drawings (SCDs) prepared by Engineering and Product Assurance. Specifications per the SCD are performance, test, qualification, and acceptance requirements for a procured piece of equipment. Parts. materials, processes, and design guidelines for the HTVC program are specified in accordance with Lockheed Harlin 3267828. This document defines the program requirements.

MIL-STD-975G will serve as the primary EEE parts selection document. If a suitable part cannot be found in MIL-STD-975G, equivalent EEE parts that meet the following criteria may be substituted.

Microcircults are at least Class B level, MiL-M-38510 devices. All microcircuits are subjected to Particle Impact Noise Detection (PIND) testing per MI1-510-883C (except for devices with plastic epoxytype package).

Diodes and transistors are at least JANTXV in accordance with MIL-5-19500. All semi-conductors in cavity-type packages are subjected to PINO testing per MIL-510-8830.

DESIGN FEATURES (Cont.)

Relays are procured to the highest military ostablished reliability (MIL-ER) level as defined in MIL-R-39016. Relays are subject to PIND testing.

Switches are procured to at least the second highest level of the appropriate MIL-ER specification. Switches are subjected to either PINO testing or X-ray analysis as appropriate, for particle delection.

Other discrete parts are procured to at least the second highest level of the appropriate MTL-CR specification.

Parts not included in the above documents have been used in the design only after a non-standard parts acceptance request (MSPAK) has been prepared, submitted to Reliability Assurance Engineering and approved for use in the specific application(s) defined in the NSPAK by MASA-JSC.

Worst case circuit analyses have been performed and documented for all circuit designs to demonstrate that sufficient operating margins exist for all operating conditions. The analysis was worst case in that the value for each of the variable parameters was set to limits that will drive the output to a maximum (or min.) A component approach review and analysis was conducted to verify that the applied stress on each piece part by the temperature extremes identified with environmental qualification testing does not enceed the stress denating values identified in Lockheed Martin 3267028.

DESIGN FEATURES (Cont.)

In addition, an objective examination of the design was performed through a Preliminary Design Review and Critical Design Review to verify that the ITVC met specification and contractual requirements.

BAKE BOARO DESTUR All boards are constructed from laminated copper-clad epoxy glass sheets per-MIL-P-13949 Type GF Grade A. Circuit connections are made through printed traces which run from point to point on the board surfaces. Every trace terminates at an annular ring. The annular ring surrounds the hole in which a component lead or terminal is located. This ring provides a footing for the solder, ensuring good mechanical and electrical performance. Its \$120 and shape are governed by H1L-P-\$5640. as are trace widths, spacing and routing. These requirements are reiterated specifically in drawing notes to further assure compliance. Variations between the artwork master and the final product (due to irregularities of the etching process) are also controlled by drawing notes. This prevents making defective boards from good artwork. Holes which bouse no lead or terminal, but serve only to electrically interconnect the different board layers,

The through holes are drilled from a drill tape thus eliminating the possibility of human error and allowing tight control over hole and annular ring concentricity, an important reliability criterion. After drilling and etching, all copper cladding

contain stitch bars for mechanical support

and increased reliability.

PATIDNALE FOR ACCEPTANCE. (Continued)

MARE BUARD DESIGN (Cont.)
is tim-lead plated per MIL-S10-1495. This
provides for easy and reliable soldering
at the time of board assembly, even after
periods of prolonged starage.

MOARD ASSEKULY DESIGN

All components are installed in a manner which assures maximum reliability. Component leads are pre-tinned, allowing total welling of solder joints. All leads are formed to provide stress relief and the hodies of large components are staked. Special mounting and handling instructions are included in each drawing required after final assembly. The board is coated with urelbane which protects against humidity and contamination.

ACCEPTANCE TEST

Each assembly is individually tested to a NASA approved Acceptance Test Procedure TP-A1-2000/442. The Acceptance Test flow is detailed in attached (able).

QUALIFICATION FEST

The Qualification unit is identical to the Ilight unit configuration in every respect and is used solely for the purpose of qualification testing. The Qual unit must successfully complete acceptance testing prior to entering qualification testing. The Qual unit has passed testing in accordance with MASA approved test plan PN-C-20007442. The Qualification fest flow is detailed in attached Table 2.

OPERATIONAL LESIS

In order to verify that CCIV components are operational, a test must verify the health of all the command related components from the PMS (A7A1) panel switch, through the RCU, through the sync lines to the Camera/PML, to the Camera/PMU command decoder. The Lest must also verify the camera's ability to produce video, the YSU's ability to route video, and the non-itor's ability to display video. A similar test would be performed to verify the HDM command path.

Pre-Launch on Orbiter Test/In-Flight Test

- 1. Power CCTV System.
- Via the PNS panel, select a monitor as destination and the camera under test as source.
- Send "Camera Power On" command (rom the PHS panel.
- 4. Select "External Sync" on monitor.
- 5. Observe video displayed on monitor. Note that it video on monitor is synchronized li.e., stable raster) then this indicates that the camera is receiving composite sync from the RCU and that the camera is preducing synchronized video.
- Send Pan, Ti)t, Focus, Zoom, ALC, and Gamma commands and visually (either via the monitor or direct observation) verify operation.
- Select downlink as destination and camera under test as source.
- 8. Observe videa routed to downlink.
- Send "Camera Power Off" command via PHS panel.
- Repeat Steps 3 through 9 except issue commands via the MOH command path.

QAZINSPECTION

Procurement Control - The TTVC EEE Parts and bardware items are procured from approved vendors and suppliers, which meet the requirements set forth in the TTVC contract. Resident DTRD personnel review all procurement documents to establish the need for GS1 on selected parts (PAT 517).

Incoming Inspection and Storage - Incoming Quality inspections are made on all received materials and parts. Results are recorded by lot and retained in file by drawing and control numbers for future reference and traceability. All EEE parts are subjected to incoming acceptance tests as called for in PAP A4, [4 - Incoming Inspec-Lian lest Instructions. Incoming flight parts are further processed in accordance with Lockheed Martin 3267820. Mochanical items are inspected per PAP A4.14 - Supplier Quality Assurance, and PAP E10.0.1 - Procedure for Processing Incoming or Purchased Parts Designated for Flight Use. Accepted items are delivered to Haterial Controlled Stores and retained under specified conditions until Fabrication is required. Mon-conforming materials are held for Material Review Board (MRB) disposition. (PAP A4.14.)

Board Assembly & Test - Prior to the start
of TVC board assembly, all items are
verified to be correct by stock room
personnel, as the items are accumulated
to form a kit. The items are verified
again by the operator who assembles the
kit by checking against the as-builtparts-list (ANPL). OPRO Manulatory
Inspection Points are designed for all

OA/INSPECTION (Cont.)

prioted circuit, plus harness connectors for soldering wiring, crimping, solder splices and quality workmanship prior to . coating of the component side of boards and sleeving of harnesses.

OA/INSPECTION (Cont.)

ITVC Boards

Specific ITVC board assembly and test instructions are provided in drawing notes. and applicable documents are called out in the Fabrication Procedure and Record (FPR-20007442) and parts list Pt20007442. These include Process Standard-Ronding RIV-566 2700881, Process Standard - Bonding Veloro Tape 2200089, Specification Soldering 2200749, Specification - Crimping 2200000, Specification - Bonding and Staking 2200070. Specification - Urethane coating 2200027, Specification - Marking 2200076, Specification - Norkmanship 8030035, Specification Bonding and Staking 2280875, Specification-Maye Solder [228082]. Specification-Printed Wire Board Staking 2200051, Specification-Reflow Soldering 2200754, Specification-Soldering Surface Mount Components 20005710.

QA/INSPECTION (Cont.)

ITVC Assembly and Test

An open how test is performed per IP-II-20007442 and an Acceptance Test per TP-AT-20007442, including vibration and thermal vacuum. Torques are specified and witnessed, tracoability numbers are recorded and calibrated Lools are checked prior to use. Lockheed Martin Quality and OPRO inspections are performed at the completion of specified FPR operations in accordance with PAP-2.6.1, PAP-2.9, PAP-2.11, PAP-E6.1, and PAP-8.5. OPRO personnel witness IIVC button-up and critical torquing.

The ITVC is packaged according to NASA documents NHB6000.1C and NHB5300.4(102) which defines packaging and handling requirements. All related documentation including assembly drawings, Parts List, ABPL, Test Data, etc., is gothered and held in a documentation folder assigned specifically to each assembly. This folder is retained for reference. An EIDP is prepared for each assembly in accordance with the requirements of PAP [2.3. Lockheed Hartin QC and QPRD personnel witness trating, packaging, packing, and marking, and review the EIOP for completeness and accuracy.

TAULE 1. ACCEPTANCE TEST FLOW

ROOM ANDIENT PERFORMANCE TEST

Test conducted per the requirements of NASA approved TP-AT-20007442.

ACCEPTANCE VIBRATION EXPOSURE

20-80 Hz; 3 dB/ogtave rise from 0.01 g²/Hz to 0.64 g²/Hz

00-350 Hz: 0.04 g²/Hz 350-2000 Hz: 3 d0/octave decrease to 0.006 g²/Hz Test Ouration: I minute/axis, operating

Test tevel: 6.1 grms

POST-VIBRATION FUNCTIONAL CHECK

lest conducted per the requirements of NASA approved 1P-AT-20007442,

4. ACCEPTANCE THERNAL-VACUUM EXPOSUGE

1.5 cycles total from +IIS deg F to +14 deg F. After stabilization, one hour minimum duration al each plateau. In-spec functional Lests performed at each plateau.

5. <u>POST-CHYTRONMUNIAL PERFORMANCE JEST</u>

Room ambient performance tests conducted in accordance with NASA approved TP-AT-20007442.

TABLE 2. QUALTECATION TEST FLOW

I. [M]

Conducted tests run in accordance with the requirements of \$1-E-QUQZB, including CSQ1. CSD2, CSD6, TID1, CED1, and CED3. Radiated tests run in accordance with SL-E-DODZB including KSD2, RSD3, and RED2 except that the test current for MSOZ was 2 amps in lieu of 20 anips.

QUAL_FOR_ACCEPTANCE_VIDRATION

20-00 Hz: 3 dB/octave increasing to 0.067 g^2/Hz

80-350 Hz: 0.067/octave

350-2000 Hz: 3 d8/actave decrease

lest Level: 7.8 grms

Test Duration: 5 minutes/axis; operating

3. ELIGHE QUALIFICATION YIBRALION

20-70 Hz: θ dB/ogtave increasing to 0.4 θ^2/Hz

70-500 Hz; 0.4 g²/Hz

500-2000 llz: 6 dD/octave decrease

Test Level: 18.1 gms

Test Duration: 40 minutes/axis non-operating

4. IJERMAL-VACUUM

7.5 cycles total from +120 deg F to +9 deg F. After stabilization, one hour minimum duration at each plateau. In-spec functional tests performed at each plateau.

INFRHAL SIMULATION

Hurst rase but and cold mission environments simulated in vacuum. During hat case, In-spec operation is required for 6 of 14 consecutive hours. During cold case, in-spec operation is required for 14 consecutive hours.

6. AUMIDITY

120 hours exposure to 85% RH including four 24 hour temperature cycles of +60 deg F to +125 deg non-operating.